Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/711,015	CHEN ET AL.	
Examiner	Art Unit	
Kevin Quinto	2826	

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INTERFERENCE SEARCHED					
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
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438/637,687	4/4/06	n			
(text limited - FLL printing) 41410V				
438/637, 687 (text limited—rec printed EAST BAS (USPAT PERUS) EQU. 190,	4/38/06				
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